

RELIABILITY MONITOR

PRODUCT	MONITOR DATE	DATE CODE	ASSEMBLY FACILITY	ASSEMBLY LOT NO	PROCESS TYPE	PACKAGE TYPE
DS12885	Jul-96	9624 A2	HYUNDAI	DL615571AAB	1.2μ OX/NI	24 PDIP

STRESS/JOB NO.

READPOINT (Sample Size/No. of Fails)

Infant / High Voltage Life 125°C, 7.0 V. P-17815, P-17847	<table border="0"> <tr> <td><u>48 Hr</u></td> <td><u>336 Hr</u></td> <td><u>1KHr</u></td> <td><u>*Failure Rate</u></td> </tr> <tr> <td>233/1</td> <td>77/0</td> <td>77/0</td> <td>66 Fits</td> </tr> <tr> <td>F1</td> <td></td> <td></td> <td></td> </tr> </table>	<u>48 Hr</u>	<u>336 Hr</u>	<u>1KHr</u>	<u>*Failure Rate</u>	233/1	77/0	77/0	66 Fits	F1			
<u>48 Hr</u>	<u>336 Hr</u>	<u>1KHr</u>	<u>*Failure Rate</u>										
233/1	77/0	77/0	66 Fits										
F1													

*Chi Squared Method, 60% C. L., 55°C & 5.5V; Temperature Derating: Ea = 0.7 ev; Voltage Derating B = 1.0

Temp Cycle -55°C to +125°C P-17848	<table border="0"> <tr> <td><u>300 ~</u></td> <td><u>1K ~</u></td> <td><u>Cum %</u></td> </tr> <tr> <td>38/0</td> <td>38/0</td> <td>0.0%</td> </tr> </table>	<u>300 ~</u>	<u>1K ~</u>	<u>Cum %</u>	38/0	38/0	0.0%
<u>300 ~</u>	<u>1K ~</u>	<u>Cum %</u>					
38/0	38/0	0.0%					

Biased Moisture (HAST) 120°C/85% RH, 5.5 V. P-17849	<table border="0"> <tr> <td><u>100 Hr</u></td> <td><u>Cum %</u></td> </tr> <tr> <td>77/0</td> <td>0.0%</td> </tr> </table>	<u>100 Hr</u>	<u>Cum %</u>	77/0	0.0%
<u>100 Hr</u>	<u>Cum %</u>				
77/0	0.0%				

Autoclave 121°C/100% RH, 2 Atmos P-17850	<table border="0"> <tr> <td><u>96 Hr</u></td> <td><u>Cum %</u></td> </tr> <tr> <td>38/0</td> <td>0.0%</td> </tr> </table>	<u>96 Hr</u>	<u>Cum %</u>	38/0	0.0%
<u>96 Hr</u>	<u>Cum %</u>				
38/0	0.0%				

Failure Mode

F1: lcc

Failure Analysis

In process, 960220